

Issue Classification

WEI ZHEN
SUPERVISORY PATENT EXAMINER
JIN FANG
WEI ZHEN
(Primary Examiner) (Date)

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant	<input type="checkbox"/> CPA	<input type="checkbox"/> T.D.	<input type="checkbox"/> R.1.47
----------------------------------------------------------------------------------------	------------------------------	-------------------------------	---------------------------------